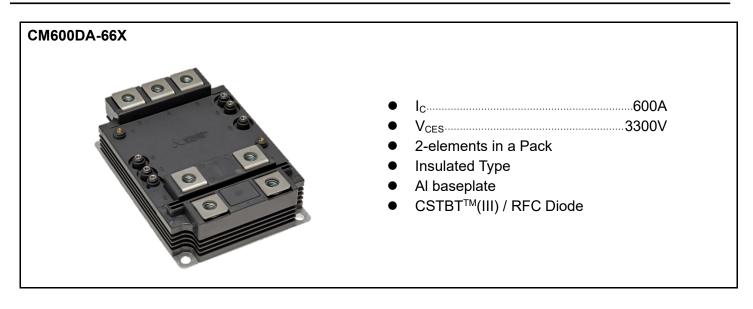


< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

### **CM600DA-66X**

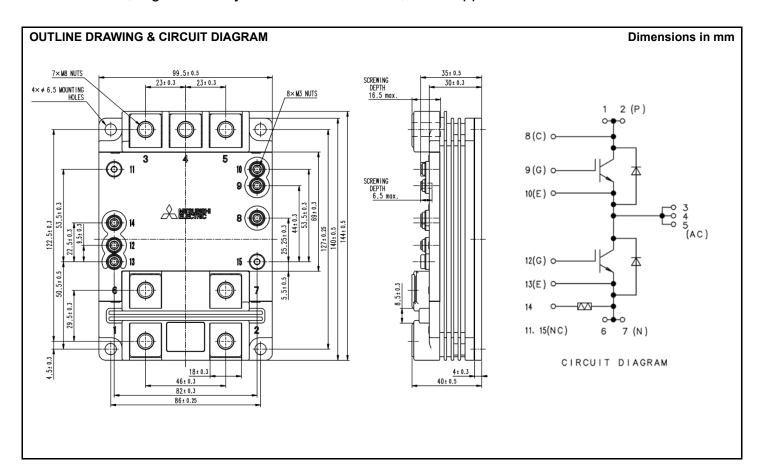
HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



#### **APPLICATION**

Traction drives, High Reliability Converters / Inverters, DC choppers



#### < High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

### **CM600DA-66X**

HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **MAXIMUM RATINGS**

Symbol	Item	Conditions	Ratings	Unit
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V, T_j = -40+150$ °C	3300	V
		$V_{GE} = 0V, T_j = -50^{\circ}C$	3200	V
$V_{GES}$	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	± 20	V
Ic	Callantan aumant	DC, T <sub>c</sub> = 109°C	600	Α
I <sub>CRM</sub>	Collector current	Pulse (Note 1)	1200	Α
IE	Emittor current (Note 2)	DC, T <sub>c</sub> = 90°C	600	Α
I <sub>ERM</sub>	Emitter current (Note 2)	Pulse (Note 1)	1200	Α
P <sub>tot</sub>	Maximum power dissipation (Note 3)	T <sub>c</sub> = 25°C, IGBT part	5400	W
V <sub>iso</sub>	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min., T <sub>C</sub> = 25°C	6000	V
V <sub>e</sub>	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, Q <sub>PD</sub> ≤ 10 pC., T <sub>C</sub> = 25°C	2600	V
T <sub>i</sub>	Junction temperature		<b>−50 ~ +150</b>	°C
T <sub>jop</sub>	Operating junction temperature		<b>−50 ~ +150</b>	°C
$T_{stg}$	Storage temperature		<b>−</b> 55 ~ <b>+</b> 125	°C
t <sub>psc</sub>	Short circuit pulse width	$V_{CC} = 2400V, V_{CE} \le V_{CES}, V_{GE} = 15V, T_j = 150$ °C $R_{g(on)} = 2.2\Omega, R_{g(off)} = 51\Omega, C_{GE} = 33nF$	10	μs

#### **ELECTRICAL CHARACTERISTICS**

0	H	Item Conditions			Limits		1.1
Symbol	item			Min	Тур	Max	Unit
			T <sub>i</sub> = 25°C	_	_	2.0	mA
I <sub>CES</sub>	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	T <sub>i</sub> = 125°C	_	2.0	_	
			T <sub>i</sub> = 150°C	_	20.0	_	
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	$V_{CE} = 10 \text{ V}, I_{C} = 60 \text{ mA}, T_{j} = 25^{\circ}\text{C}$		6.5	7.0	7.5	V
I <sub>GES</sub>	Gate leakage current	$V_{GE} = V_{GES}$ , $V_{CE} = 0V$ , $T_j = 25$ °C		-0.5	_	0.5	μΑ
C <sub>ies</sub>	Input capacitance	\\ -10\\\\ -0\\ f-100\\\		_	53.4	_	nF
Coes	Output capacitance	$V_{CE} = 10 \text{ V}, V_{GE} = 0 \text{ V}, f = 100 \text{ kHz}$ $T_i = 25^{\circ}\text{C}$		_	3.8	_	nF
C <sub>res</sub>	Reverse transfer capacitance	1 <sub>j</sub> - 25 C		_	0.5	_	nF
$Q_G$	Total gate charge	$V_{CC} = 1800V$ , $I_{C} = 600A$ , $V_{GE} = \pm 15V$		_	3.6	_	μC
		L COO A (Note 4)	T <sub>j</sub> = 25°C	_	2.30	_	
$V_{CEsat}$	Collector-emitter saturation voltage	$I_C = 600 \text{ A}^{\text{(Note 4)}}$	T <sub>i</sub> = 125°C	_	2.80	3.20	V
		V <sub>GE</sub> = 15 V	T <sub>i</sub> = 150°C	_	2.90	3.30	
	Turn-on delay time		T <sub>i</sub> = 125°C	_	_	1.25	μs
$t_{d(on)}$		$V_{CC} = 1800 \text{ V}$ $I_{C} = 600 \text{ A}$ $V_{GE} = \pm 15 \text{ V}$ $R_{G(on)} = 2.2 \Omega$	T <sub>i</sub> = 150°C	_	_	1.25	
	Rise time		T <sub>i</sub> = 125°C	_	_	0.50	μs
t <sub>r</sub>			T <sub>i</sub> = 150°C	_	_	0.50	
	Turn-on switching energy (Note 5) per pulse		T <sub>i</sub> = 25°C	_	0.76	_	J
E <sub>on(10%)</sub>			T <sub>i</sub> = 125°C	_	0.92	_	
		$L_s = 65 \text{nH}$	T <sub>i</sub> = 150°C	_	0.93	_	
	Turn-on switching energy (Note 6) per pulse	Inductive load  C <sub>GE</sub> = 33 nF	T <sub>i</sub> = 25°C	_	0.82	_	J
E <sub>on</sub>		GE - 33 IIF	T <sub>i</sub> = 125°C	_	0.99	_	
			T <sub>i</sub> = 150°C	_	1.00	_	
	Turn-off delay time		T <sub>i</sub> = 25°C	_	3.40	_	
$t_{d(off)}$			T <sub>i</sub> = 125°C	_	3.60	5.00	μs
			T <sub>i</sub> = 150°C	_	3.65	5.00	
		V <sub>CC</sub> = 1800 V	T <sub>i</sub> = 25°C	_	0.23	_	
t <sub>f</sub>	Fall time	$I_{\rm C} = 600  {\rm A}$	T <sub>i</sub> = 125°C	_	0.33	1.00	μs
		$V_{GE} = \pm 15 \text{ V}$	T <sub>i</sub> = 150°C	_	0.35	1.00	-
	Turn off switching operay (Note 5)	$R_{G(off)} = 51 \Omega$	T <sub>i</sub> = 25°C	_	0.67		
E <sub>off(10%)</sub>	Turn-off switching energy (Note 5) per pulse	L <sub>s</sub> = 65nH Inductive load	T <sub>i</sub> = 125°C	_	0.91	_	J
		C <sub>GE</sub> = 33 nF	T <sub>j</sub> = 150°C	_	0.92	_	
	Turn-off switching energy (Note 6)	OGE - 33 III	T <sub>j</sub> = 25°C	_	0.76		
E <sub>off</sub>	runi-on switching energy		T <sub>i</sub> = 125°C	_	1.03	_	J
	per pulse		T <sub>i</sub> = 150°C	_	1.04	_	

#### < High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

### **CM600DA-66X**

HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

**ELECTRICAL CHARACTERISTICS (continuation)** 

Cumbal	Item		Conditions			Limits		Unit
Symbol			Conditions			Тур	Max	Offic
			1 000 A (Note 4)	T <sub>j</sub> = 25°C	-	2.10	_	V
$V_{EC}$	Emitter-collector voltage	(Note 2)	$I_E = 600 \text{ A}^{\text{(Note 4)}}$	T <sub>j</sub> = 125°C	_	2.30	2.80	
			$V_{GE} = 0 V$	T <sub>j</sub> = 150°C	_	2.40	2.90	
				T <sub>j</sub> = 25°C	-	0.55	_	
t <sub>rr</sub>	Reverse recovery time	(Note 2)		T <sub>j</sub> = 125°C	1	0.65	_	μs
				T <sub>j</sub> = 150°C	_	0.70	_	
				T <sub>j</sub> = 25°C	_	1170	_	А
Irr	Reverse recovery current (Note 2)	(Note 2)		$T_{j} = 125^{\circ}C$	_	1120		
				$T_{j} = 150^{\circ}C$	_	1100	_	
	Reverse recovery charge (Note 2.7		V <sub>CC</sub> = 1800 V	$T_j = 25^{\circ}C$	_	620		μC
Q <sub>rr(10%)</sub>		(Note 2,7)	V <sub>GE</sub> = ±15 V	T <sub>i</sub> = 125°C		740	_	
				$T_{i} = 150^{\circ}C$		770		
	Reverse recovery charge (Note 2,6)		$R_{G(on)} = 2.2 \Omega$ $L_s = 65 \text{ nH}$	$T_j = 25^{\circ}C$	_	650		
$Q_{rr}$		(Note 2,6)	Inductive load  C <sub>GE</sub> = 33 nF	$T_{j} = 125^{\circ}C$	_	805		μC
				$T_{i} = 150^{\circ}C$		845		
	Reverse recovery energy (Note 2,5) per pulse	(Note 2,5)		$T_j = 25^{\circ}C$	_	0.66		
E <sub>rec(10%)</sub>		, , , , ,		$T_j = 125^{\circ}C$		0.88	_	J
				$T_{i} = 150^{\circ}C$		0.91	_	
	Reverse recovery energy (Note 2,6) per pulse	(Note 2,6)		T <sub>i</sub> = 25°C	_	0.75	_	
E <sub>rec</sub>		,,-,		$T_{j} = 125^{\circ}C$	_	1.01		J
			T <sub>j</sub> = 150°C	_	1.03	_		

#### THERMAL CHARACTERISTICS

Coursels al	Item	Conditions		Limits		
Symbol				Тур	Max	Unit
$R_{th(j-c)Q}$	Thermal registeres	Junction to Case, IGBT part , 1/2 module			20.5	K/kW
$R_{th(j-c)D}$	Thermal resistance	Junction to Case, FWDi part, per 1/2 module		_	34.0	K/kW
R <sub>th(c-s)</sub>	Contact thermal resistance	Case to heat sink, 1/2 module $\lambda_{grease}$ = 1W/m*k, $D_{(c-s)}$ = 70 $\mu$ m	-	16.0	_	K/kW

#### < High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

### CM600DA-66X

HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### NTC THERMISTOR PART

Comple al	Item	Conditions	Limits			1.124
Symbol			Min	Тур	Max	Unit
R <sub>25</sub>	Zero-power resistance	T <sub>c</sub> =25°C	-	5.00	ı	kΩ
B <sub>(25/50)</sub>	B-constant (Note 8)	Approximate by equation		3375	•	K

#### **MECHANICAL CHARACTERISTICS**

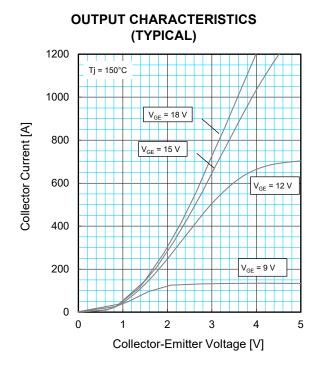
Comple al	Item	Conditions		Limits			
Symbol				Тур	Max	Unit	
Mt		Main terminals screw M8	7.0	_	14.0	N·m	
Ms	Mounting torque	Mounting screw M6	3.0	_	6.0	N·m	
M <sub>t</sub>		Auxiliary terminals screw M3	0.4	_	8.0	N·m	
m	Mass		_	0.75	_	kg	
CTI	Comparative tracking index		600	_		-	
d <sub>a</sub>	Clearance	Between terminals and baseplate	19.5	_		mm	
ds	Creepage distance	Between terminals and baseplate	32.0	_		mm	
L <sub>P P-N</sub>	Parasitic stray inductance	Between terminal 1, 2 and terminal 3, 4		10.0	1	nΗ	
R <sub>CC'+EE'</sub>	Internal lead resistance	T <sub>C</sub> = 25 °C, 1/2 module	_	0.41		mΩ	
$r_g$	Internal gate resistance	T <sub>C</sub> = 25 °C		0.83	_	Ω	

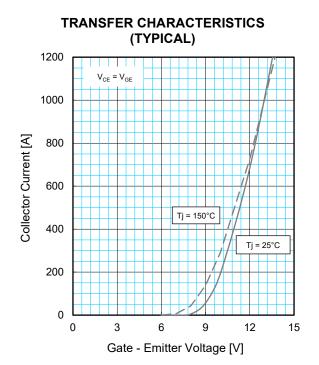
Note1. Pulse width and repetition rate should be such that junction temperature (Tj) does not exceed Tjopmax rating.

- 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD<sub>i</sub>).
- 3. Junction temperature  $(T_j)$  should not exceed  $T_{jmax}$  rating (150°C).
- 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- 5. The integration range of switching energies is from  $10\% V_{CE}$  to  $10\% I_{C}(10\% I_{E}).$
- 6. Definition of all items is according to IEC 60747, unless otherwise specified.
- 7. The integration range of reverse recovery charge is from  $I_E$  = 0A to 10% $I_E$ .

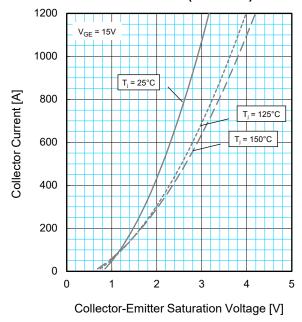
8. 
$$B_{(25/50)} = \ln \left(\frac{R_{25}}{R_{50}}\right) / \left(\frac{1}{T_{25}} - \frac{1}{T_{50}}\right)$$

 $R_{25}\text{: resistance at absolute temperature }T_{25}\text{ [K]};\ T_{25}\text{ = }25[^{\circ}\text{C}]\text{ + }273.15\text{ = }298.15\text{[K]}\\ R_{50}\text{: resistance at absolute temperature }T_{25}\text{ [K]};\ T_{50}\text{ = }50[^{\circ}\text{C}]\text{ + }273.15\text{ = }323.15\text{[K]}\\$ 

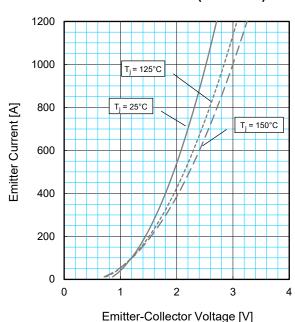




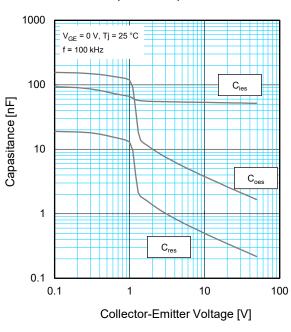
### COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



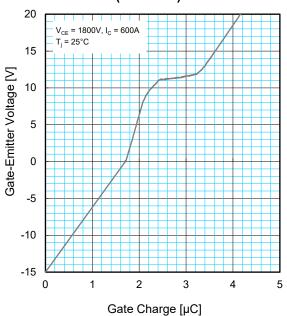
# FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



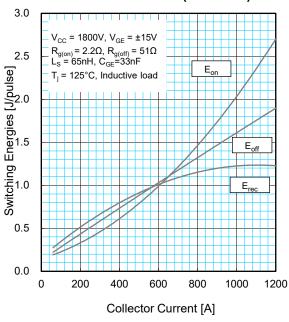
# CAPACITANCE CHARACTERISTICS (TYPICAL)



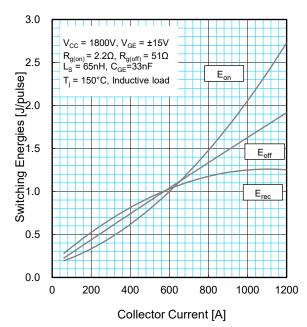
## GATE CHARGE CHARACTERISTICS (TYPICAL)



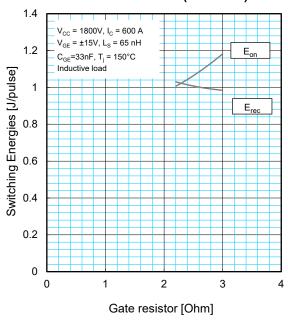
# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



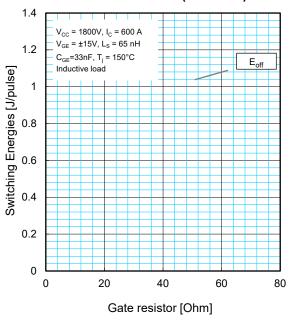
# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



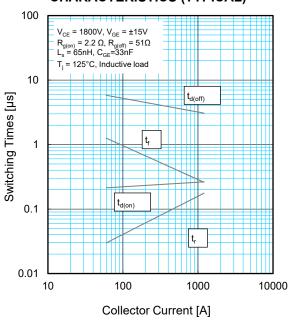
### HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



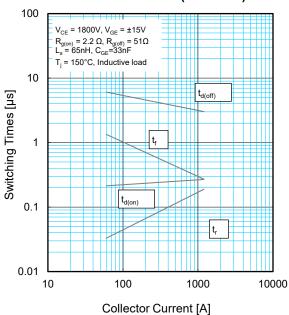
### HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



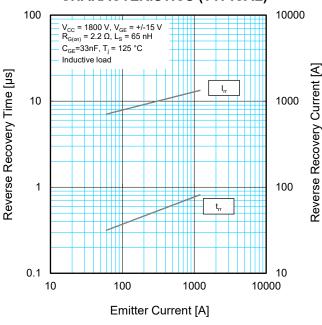
## HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



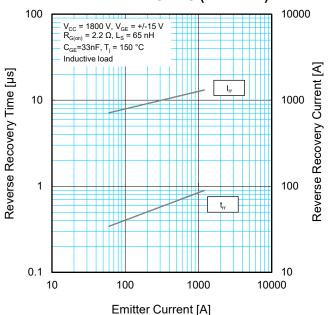
## HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



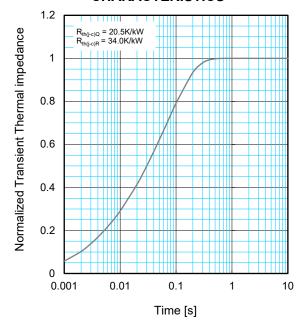
### FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



# FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



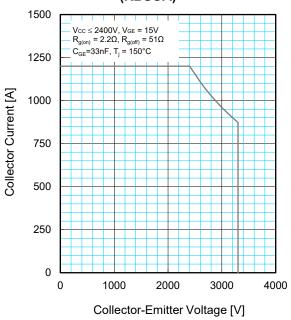
# TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



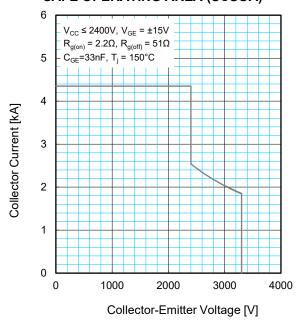
$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

	1	2	3	4
R <sub>i</sub> /R <sub>th</sub> :	0.0292	0.0832	0.2277	0.6599
τ <sub>i</sub> [sec.] :	0.0025	0.0027	0.0155	0.0865

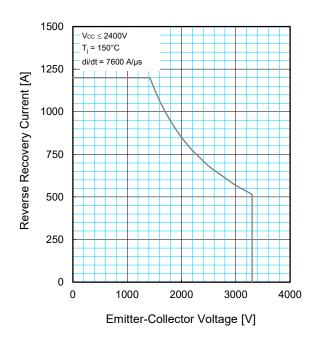
# REVERSE BIAS SAFE OPERATING AREA (RBSOA)



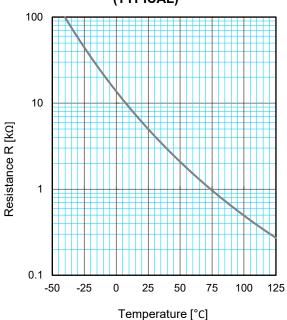
### SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



## FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



# NTC THERMISTOR TEMPERATURE CHARACTERISTICS (TYPICAL)



CM600DA-66X
HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **Important Notice**

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5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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